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## **Minimum bias and underlying event measurements with CMS**

*Wednesday, 5 April 2017 11:20 (20 minutes)*

We present results on the measurement of the underlying event at 13 TeV using leading tracks, jets, and Drell-Yan processes. In addition measurements of forward-backward particle correlations and the rapidity gap fraction are presented. Finally results on charged particle multiplicity and transverse momenta distributions are shown.

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**Session Classification:** WG2 Low x and Diffraction

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